

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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NGTD20T120F2

IGBT Die

Trench Field Stop II IGBT Die for motor drive and inverter applications.

Features

- Extremely Efficient Trench with Field Stop Technology
- Low $V_{CE(sat)}$ Loss Reduces System Power Dissipation

Typical Applications

- Industrial Motor Drives
- Solar Inverters
- UPS Systems
- Welding

MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Collector-Emitter Voltage, $T_J = 25^\circ\text{C}$	V_{CE}	1200	V
DC Collector Current, limited by $T_{J(\text{max})}$	I_C	(Note 1)	A
Pulsed Collector Current (Note 2)	$I_{C, \text{pulse}}$	100	A
Gate-Emitter Voltage	V_{GE}	± 20	V
Maximum Junction Temperature	T_J	-55 to $+175$	$^\circ\text{C}$
Short Circuit Withstand Time, $V_{GE} = 15 \text{ V}$, $V_{CE} = 500 \text{ V}$, $T_J \leq 150^\circ\text{C}$	T_{SC}	10	μs

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Depending on thermal properties of assembly.
2. T_{pulse} limited by $T_{j(\text{max})}$, 10 μs pulse, $V_{GE} = 15 \text{ V}$.

MECHANICAL DATA

Parameter	Value	Unit
Die Size	5129 x 3695	μm^2
Emitter Pad Size	See die layout	μm^2
Gate Pad Size	400 x 670	μm^2
Die Thickness	5	mils
Wafer Size	150	mm
Top Metal	5 μm AlSi	
Back Metal	2 μm TiNiAg	
Max possible chips per wafer	766	
Passivation frontside	Oxide-Nitride	
Reject ink dot size	25 mils	
Recommended storage environment: In original container, in dry nitrogen, or temperature of 18–28°C, 30–65%RH	Type: Bare Wafer in Jar Storage time: < 36 months	Type: Die on tape in ring-pack Storage time: < 3 months

ORDERING INFORMATION

Device	Inking?	Shipping
NGTD20T120F2WP	Yes	Bare Wafer in Jar
NGTD20T120F2SWK	Yes	Sawn Wafer on Tape



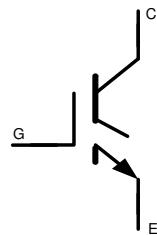
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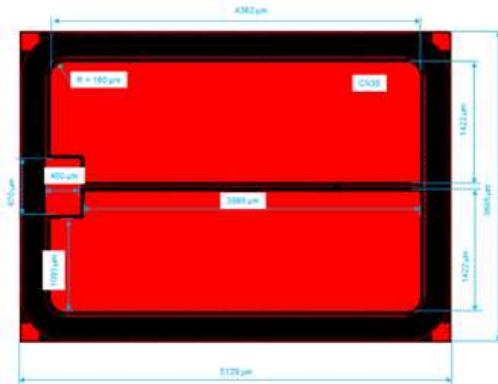
$V_{RCE} = 1200 \text{ V}$

$I_C = \text{Limited by } T_{J(\text{max})}$

IGBT DIE



DIE OUTLINE



ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, unless otherwise specified)

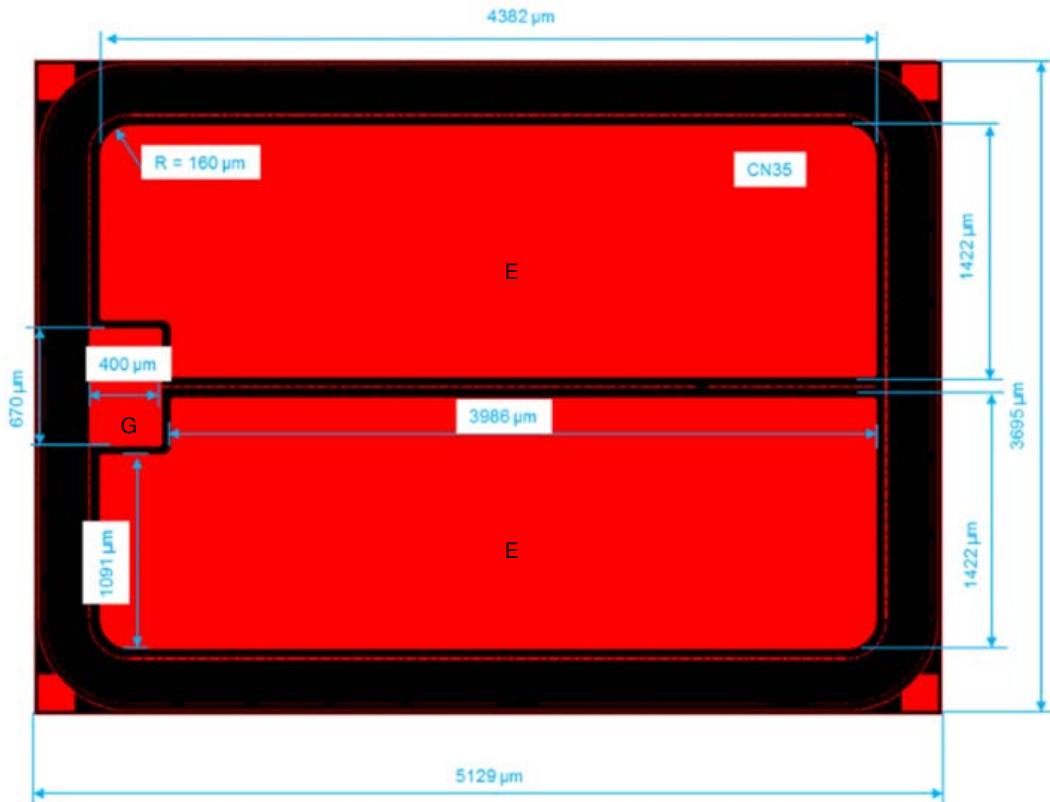
Parameter	Test Conditions	Symbol	Min	Typ	Max	Units
STATIC CHARACTERISTICS						
Collector-Emitter Breakdown Voltage	$V_{GE} = 0 \text{ V}$, $I_C = 500 \mu\text{A}$	$V_{(BR)CES}$	1200			V
Collector-Emitter Saturation Voltage	$V_{GE} = 15 \text{ V}$, $I_C = 20 \text{ A}$	$V_{CE(\text{sat})}$		2.0	2.4	V
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 400 \mu\text{A}$	$V_{GE(\text{TH})}$	4.5	5.5	6.5	V
Collector-Emitter Cutoff Current	$V_{GE} = 0 \text{ V}$, $V_{CE} = 1200 \text{ V}$	I_{CES}			0.4	mA
Gate Leakage Current	$V_{GE} = 20 \text{ V}$, $V_{CE} = 0 \text{ V}$	I_{GES}			200	nA

DYNAMIC CHARACTERISTICS

Input Capacitance	$V_{CE} = 20 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 1 \text{ MHz}$	C_{ies}	4420		pF
Output Capacitance		C_{oes}	151		pF
Reverse Transfer Capacitance		C_{res}	81		pF

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

DIE LAYOUT



E = Emitter pad

G = Gate pad

All dimensions in μm

Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

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